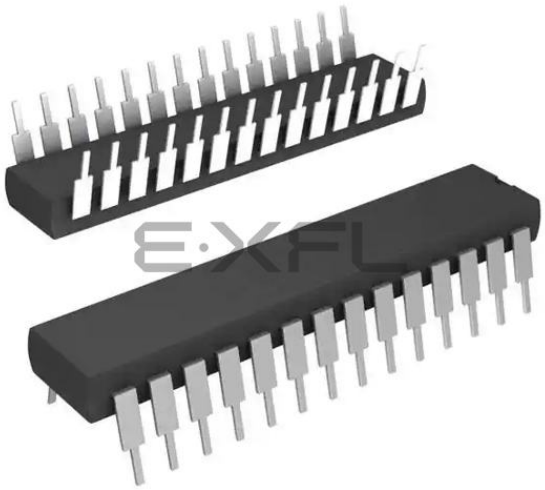

Welcome to E-XFL.COM

What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Obsolete
Core Processor	eZ8
Core Size	8-Bit
Speed	20MHz
Connectivity	IrDA, UART/USART
Peripherals	Brown-out Detect/Reset, LED, LVD, POR, PWM, Temp Sensor, WDT
Number of I/O	23
Program Memory Size	1KB (1K x 8)
Program Memory Type	FLASH
EEPROM Size	16 x 8
RAM Size	256 x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 3.6V
Data Converters	A/D 8x10b
Oscillator Type	Internal
Operating Temperature	0°C ~ 70°C (TA)
Mounting Type	Through Hole
Package / Case	28-DIP (0.600", 15.24mm)
Supplier Device Package	-
Purchase URL	https://www.e-xfl.com/product-detail/zilog/z8f012apj020sg

Revision History

Each instance in this document's revision history reflects a change from its previous edition. For more details, refer to the corresponding page(s) or appropriate links furnished in the table below.

Date	Revision Level	Chapter/Section	Description	Page No.
Dec 2012	27	Port Alternate Function Mapping (Non 8-Pin Parts), Port Alternate Function Mapping (8-Pin Parts)	Added missing Port D data to Table 15; corrected active Low status (set overlines) for PA0 ($\overline{T0OUT}$), PA2 ($\overline{RESET}$) and PA5 ($\overline{T1OUT}$) in Table 16.	40, 43
Sep 2011	26	LED Drive Enable Register	Clarified statement surrounding the Alternate Function Register as it relates to the LED function; revised Flash Sector Protect Register description; revised Packaging chapter.	53, 157, 245
Sep 2008	25	Overview, Address Space, Register Map, General-Purpose Input/Output, Available Packages, Ordering Information	Added references to F042A Series back in Table 1, Table 5, Table 7 and Table 14.	2, 8, 16, 18, 36, 246
May 2008	24	Overview, Address Space, Register Map, General-Purpose Input/Output, Available Packages, Ordering Information	Changed title to Z8 Encore! XP F082A Series and removed references to F042A Series in Table 1, Table 5, Table 7 and Table 14.	2, 8, 16, 18, 36, 246
Dec 2007	23	Pin Description, General-Purpose Input/Output, Watchdog Timer	Updated Figure 3, Table 15, Tables 60 through 62.	9, 40, 97
Jul 2007	22	Electrical Characteristics	Updated Tables 16 and 132; power consumption data.	43, 229
Jun 2007	21	n/a	Revision number update.	All

Table of Contents

warning signal. The $\overline{\text{RESET}}$ pin is bidirectional, that is, it functions as reset source and as a reset indicator.

Table 2. Signal Descriptions (Continued)

Signal Mnemonic	I/O	Description
Analog		
ANA[7:0]	I	Analog Port. These signals are used as inputs to the analog-to-digital converter (ADC).
VREF	I/O	Analog-to-digital converter reference voltage input, or buffered output for internal reference.
Low-Power Operational Amplifier (LPO)		
AMPINP/AMPINN	I	LPO inputs. If enabled, these pins drive the positive and negative amplifier inputs respectively.
AMPOUT	O	LPO output. If enabled, this pin is driven by the on-chip LPO.
Oscillators		
XIN	I	External Crystal Input. This is the input pin to the crystal oscillator. A crystal can be connected between it and the X_{OUT} pin to form the oscillator. In addition, this pin is used with external RC networks or external clock drivers to provide the system clock.
X_{OUT}	O	External Crystal Output. This pin is the output of the crystal oscillator. A crystal can be connected between it and the **XIN** pin to form the oscillator.
Clock Input		
CLKIN	I	Clock Input Signal. This pin may be used to input a TTL-level signal to be used as the system clock.
LED Drivers		
LED	O	Direct LED drive capability. All port C pins have the capability to drive an LED without any other external components. These pins have programmable drive strengths set by the GPIO block.
On-Chip Debugger		
DBG	I/O	Debug. This signal is the control and data input and output to and from the On-Chip Debugger. **Caution:** The DBG pin is open-drain and requires a pull-up resistor to ensure proper operation.

Notes:
1. PB6 and PB7 are only available in 28-pin packages without ADC. In 28-pin packages with ADC, they are replaced by AV_{DD} and AV_{SS}.
2. The AV_{DD} and AV_{SS} signals are available only in 28-pin packages with ADC. They are replaced by PB6 and PB7 on 28-pin packages without ADC.

Reset Sources

Table 9 lists the possible sources of a system reset.

Table 9. Reset Sources and Resulting Reset Type

Operating Mode	Reset Source	Special Conditions
NORMAL or HALT modes	Power-On Reset/Voltage Brown-Out	Reset delay begins after supply voltage exceeds POR level.
	Watchdog Timer time-out when configured for Reset	None.
	$\overline{\text{RESET}}$ pin assertion	All reset pulses less than three system clocks in width are ignored.
	On-Chip Debugger initiated Reset (OCDCTL[0] set to 1)	System Reset, except the On-Chip Debugger is unaffected by the reset.
STOP Mode	Power-On Reset/Voltage Brown-Out	Reset delay begins after supply voltage exceeds POR level.
	$\overline{\text{RESET}}$ pin assertion	All reset pulses less than the specified analog delay are ignored. See Table 131 on page 229.
	DBG pin driven Low	None.

Power-On Reset

Z8 Encore! XP F082A Series devices contain an internal Power-On Reset circuit. The POR circuit monitors the supply voltage and holds the device in the Reset state until the supply voltage reaches a safe operating level. After the supply voltage exceeds the POR voltage threshold (V_{POR}), the device is held in the Reset state until the POR Counter has timed out. If the crystal oscillator is enabled by the option bits, this time-out is longer.

After the Z8 Encore! XP F082A Series device exits the Power-On Reset state, the eZ8 CPU fetches the Reset vector. Following Power-On Reset, the POR status bit in the Reset Status (RSTSTAT) Register is set to 1.

Figure 5 displays Power-On Reset operation. See Electrical Characteristics on page 221 for the POR threshold voltage (V_{POR}).

Table 15. Port Alternate Function Mapping (Non 8-Pin Parts) (Continued)

Port	Pin	Mnemonic	Alternate Function Description	Alternate Function Set Register AFS1
Port B[3]	PB0	Reserved		AFS1[0]: 0
		ANA0/AMPOUT	ADC Analog Input/LPO Output	AFS1[0]: 1
	PB1	Reserved		AFS1[1]: 0
		ANA1/AMPINN	ADC Analog Input/LPO Input (N)	AFS1[1]: 1
	PB2	Reserved		AFS1[2]: 0
		ANA2/AMPINP	ADC Analog Input/LPO Input (P)	AFS1[2]: 1
	PB3	CLKIN	External Clock Input	AFS1[3]: 0
		ANA3	ADC Analog Input	AFS1[3]: 1
	PB4	Reserved		AFS1[4]: 0
		ANA7	ADC Analog Input	AFS1[4]: 1
	PB5	Reserved		AFS1[5]: 0
		V_{REF}[4]	ADC Voltage Reference	AFS1[5]: 1
	PB6	Reserved		AFS1[6]: 0
		Reserved		AFS1[6]: 1
	PB7	Reserved		AFS1[7]: 0
		Reserved		AFS1[7]: 1

Notes:
1. Because there is only a single alternate function for each Port A pin, the Alternate Function Set registers are not implemented for Port A. Enabling alternate function selections automatically enables the associated alternate function. See the Port A–D Alternate Function Subregisters (PxAF) section on page 47 for details.
2. Whether PA0/PA6 takes on the timer input or timer output complement function depends on the timer configuration. See the Timer Pin Signal Operation section on page 84 for details.
3. Because there are at most two choices of alternate function for any pin of Port B, the Alternate Function Set Register AFS2 is not used to select the function. Alternate function selection must also be enabled. See the Port A–D Alternate Function Subregisters (PxAF) section on page 47 for details.
4. V_{REF} is available on PB5 in 28-pin products and on PC2 in 20-pin parts.
5. Because there are at most two choices of alternate function for any pin of Port C, the Alternate Function Set Register AFS2 is not used to select the function. Alternate function selection must also be enabled. See the Port A–D Alternate Function Subregisters (PxAF) section on page 47 for details.
6. Because there is only a single alternate function for the Port PD0 pin, the Alternate Function Set registers are not implemented for Port D. Enabling alternate function selections automatically enables the associated alternate function. See the Port A–D Alternate Function Subregisters (PxAF) section on page 47 for details.

Caution: The frequency of the comparator output signal must not exceed one-fourth the system clock frequency. Further, the high or low state of the comparator output signal pulse must be no less than twice the system clock period. A shorter pulse may not be captured.

After reaching the reload value stored in the Timer Reload High and Low Byte registers, the timer generates an interrupt, the count value in the Timer High and Low Byte registers is reset to 0001H and counting resumes. Also, if the Timer Output alternate function is enabled, the Timer Output pin changes state (from Low to High or from High to Low) at timer Reload.

Observe the following steps for configuring a timer for COMPARATOR COUNTER Mode and initiating the count:

1. Write to the Timer Control Register to:
   - Disable the timer.
   - Configure the timer for COMPARATOR COUNTER Mode.
   - Select either the rising edge or falling edge of the comparator output signal for the count. This also sets the initial logic level (High or Low) for the Timer Output alternate function. However, the Timer Output function is not required to be enabled.
2. Write to the Timer High and Low Byte registers to set the starting count value. This action only affects the first pass in COMPARATOR COUNTER Mode. After the first timer Reload in COMPARATOR COUNTER Mode, counting always begins at the reset value of 0001H. Generally, in COMPARATOR COUNTER Mode the Timer High and Low Byte registers must be written with the value 0001H.
3. Write to the Timer Reload High and Low Byte registers to set the reload value.
4. If appropriate, enable the timer interrupt and set the timer interrupt priority by writing to the relevant interrupt registers.
5. If using the Timer Output function, configure the associated GPIO port pin for the Timer Output alternate function.
6. Write to the Timer Control Register to enable the timer.

In COMPARATOR COUNTER Mode, the number of comparator output transitions since the timer start is computed via the following equation:

Comparator Output Transitions = Current Count Value – Start Value

- Configure the timer for GATED Mode
- Set the prescale value

2. Write to the Timer High and Low Byte registers to set the starting count value. Writing these registers only affects the first pass in GATED Mode. After the first timer reset in GATED Mode, counting always begins at the reset value of 0001H.
3. Write to the Timer Reload High and Low Byte registers to set the reload value.
4. Enable the timer interrupt, if appropriate and set the timer interrupt priority by writing to the relevant interrupt registers. By default, the timer interrupt is generated for both input deassertion and reload events. If appropriate, configure the timer interrupt to be generated only at the input deassertion event or the reload event by setting TICONFIG field of the TxCTL0 Register.
5. Configure the associated GPIO port pin for the Timer Input alternate function.
6. Write to the Timer Control Register to enable the timer.
7. Assert the Timer Input signal to initiate the counting.

CAPTURE/COMPARE Mode

In CAPTURE/COMPARE Mode, the timer begins counting on the first external Timer Input transition. The acceptable transition (rising edge or falling edge) is set by the TPOL bit in the Timer Control Register. The timer input is the system clock.

Every subsequent acceptable transition (after the first) of the Timer Input signal captures the current count value. The Capture value is written to the Timer PWM High and Low Byte registers. When the Capture event occurs, an interrupt is generated, the count value in the Timer High and Low Byte registers is reset to 0001H and counting resumes. The INPCAP bit in TxCTL0 Register is set to indicate the timer interrupt is caused by an input capture event.

If no Capture event occurs, the timer counts up to the 16-bit Compare value stored in the Timer Reload High and Low Byte registers. Upon reaching the Compare value, the timer generates an interrupt, the count value in the Timer High and Low Byte registers is reset to 0001H and counting resumes. The INPCAP bit in TxCTL0 Register is cleared to indicate the timer interrupt is not because of an input capture event.

Observe the following steps for configuring a timer for CAPTURE/COMPARE Mode and initiating the count:

1. Write to the Timer Control Register to:
   - Disable the timer
   - Configure the timer for CAPTURE/COMPARE Mode
   - Set the prescale value

Analog-to-Digital Converter

The analog-to-digital converter (ADC) converts an analog input signal to its digital representation. The features of this sigma-delta ADC include:

- 11-bit resolution in DIFFERENTIAL Mode
- 10-bit resolution in SINGLE-ENDED Mode
- Eight single-ended analog input sources are multiplexed with general-purpose I/O ports
- 9th analog input obtained from temperature sensor peripheral
- 11 pairs of differential inputs also multiplexed with general-purpose I/O ports
- Low-power operational amplifier (LPO)
- Interrupt on conversion complete
- Bandgap generated internal voltage reference with two selectable levels
- Manual in-circuit calibration is possible employing user code (offset calibration)
- Factory calibrated for in-circuit error compensation

Architecture

Figure 19 displays the major functional blocks of the ADC. An analog multiplexer network selects the ADC input from the available analog pins, ANA0 through ANA7.

The input stage of the ADC allows both differential gain and buffering. The following input options are available:

- Unbuffered input (SINGLE-ENDED and DIFFERENTIAL modes)
- Buffered input with unity gain (SINGLE-ENDED and DIFFERENTIAL modes)
- LPO output with full pin access to the feedback path

Calibration and Compensation

The Z8 Encore! XP F082A Series ADC is factory calibrated for offset error and gain error, with the compensation data stored in Flash memory. Alternatively, you can perform your own calibration, storing the values into Flash themselves. Thirdly, the user code can perform a manual offset calibration during DIFFERENTIAL Mode operation.

Factory Calibration

Devices that have been factory calibrated contain 30 bytes of calibration data in the Flash option bit space. This data consists of 3 bytes for each input mode, one for offset and two for gain correction. For a list of input modes for which calibration data exists, see the Zilog Calibration Data section on page 168.

User Calibration

If you have precision references available, its own external calibration can be performed using any input modes. This calibration data takes into account buffer offset and nonlinearity; therefore Zilog recommends that this calibration be performed separately for each of the ADC input modes planned for use.

Manual Offset Calibration

When uncalibrated, the ADC has significant offset (see Table 139 on page 236). Subsequently, manual offset calibration capability is built into the block. When the ADC Control Register 0 sets the input mode (`ANAIN[2:0]`) to MANUAL OFFSET CALIBRATION Mode, the differential inputs to the ADC are shorted together by an internal switch. Reading the ADC value at this point produces 0 in an ideal system. The value actually read is the ADC offset. This value can be stored in nonvolatile memory (see the Nonvolatile Data Storage chapter on page 176) and accessed by user code to compensate for the input offset error. There is no provision for manual gain calibration.

Software Compensation Procedure Using Factory Calibration Data

The value read from the ADC high and low byte registers is uncompensated. The user mode software must apply gain and offset correction to this uncompensated value for maximum accuracy. The following equation yields the compensated value:

$$ADC_{comp} = (ADC_{uncomp} - OFFCAL) + ((ADC_{uncomp} - OFFCAL) \times GAINCAL) / 2^{14}$$

where GAINCAL is the gain calibration value, OFFCAL is the offset calibration value and ADC_{uncomp} is the uncompensated value read from the ADC. All values are in two's complement format.

Temperature Sensor

The on-chip Temperature Sensor allows you to measure temperature on the die with either the on-board ADC or on-board comparator. This block is factory calibrated for in-circuit software correction. Uncalibrated accuracy is significantly worse, therefore the temperature sensor is not recommended for uncalibrated use.

Temperature Sensor Operation

The on-chip temperature sensor is a Proportional to Absolute Temperature (PTAT) topology. A pair of Flash option bytes contain the calibration data. The temperature sensor can be disabled by a bit in the Power Control Register 0 section on page 33 to reduce power consumption.

The temperature sensor can be directly read by the ADC to determine the absolute value of its output. The temperature sensor output is also available as an input to the comparator for threshold type measurement determination. The accuracy of the sensor when used with the comparator is substantially less than when measured by the ADC.

If the temperature sensor is routed to the ADC, the ADC must be configured in unity-gain buffered mode (for details, see the Input Buffer Stage section on page 133). The value read back from the ADC is a signed number, although it is always positive.

The sensor is factory-trimmed through the ADC using the external 2.0 V reference. Unless the sensor is retrimmed for use with a different reference, it is most accurate when used with the external 2.0 V reference.

Because this sensor is an on-chip sensor, Zilog recommends that the user account for the difference between ambient and die temperature when inferring ambient temperature conditions.

During normal operation, the die undergoes heating that causes a mismatch between the ambient temperature and that measured by the sensor. For best results, the Z8 Encore! XP device must be placed into STOP Mode for sufficient time such that the die and ambient temperatures converge (this time is dependent on the thermal design of the system). The temperature sensor measurement must then be made immediately after recovery from STOP Mode.

The following equation defines the transfer function between the temperature sensor output voltage and the die temperature. This is needed for comparator threshold measurements.

$$V = 0.01 \times T + 0.65$$

In the above equation, T is the temperature in °C; V is the sensor output in volts.

Assuming a compensated ADC measurement, the following equation defines the relationship between the ADC reading and the die temperature:

$$T = (25/128) \times (ADC - TSCAL[11:2]) + 30$$

In the above equation, T is the temperature in C; ADC is the 10-bit compensated ADC value; and TSCAL is the temperature sensor calibration value, ignoring the two least significant bits of the 12-bit value.

See the Temperature Sensor Calibration Data section on page 171 for the location of TSCAL.

Calibration

The temperature sensor undergoes calibration during the manufacturing process and is maximally accurate at 30°C. Accuracy decreases as measured temperatures move further from the calibration point.

These serial numbers are stored in the Flash information page and are unaffected by mass erasure of the device's Flash memory. See the Reading the Flash Information Page section below and the Serialization Data section on page 173 for more details.

Randomized Lot Identification Bits

As an optional feature, Zilog is able to provide a factory-programmed random lot identifier. With this feature, all devices in a given production lot are programmed with the same random number. This random number is uniquely regenerated for each successive production lot and is not likely to be repeated.

The randomized lot identifier is a 32 byte binary value, stored in the Flash information page and is unaffected by mass erasure of the device's Flash memory. See Reading the Flash Information Page, below, and the Randomized Lot Identifier section on page 174 for more details.

Reading the Flash Information Page

The following code example shows how to read data from the Flash information area.

```
; get value at info address 60 (FE60h)
ldx FPS, #%80 ; enable access to flash info page
ld R0, #%FE
ld R1, #%60
ldc R2, @RR0 ; R2 now contains the calibration value
```

Flash Option Bit Control Register Definitions

This section briefly describes the features of the Trim Bit Address and Data registers.

Trim Bit Address Register

The Trim Bit Address (TRMADR) Register contains the target address for an access to the trim option bits (Table 86).

Table 86. Trim Bit Address Register (TRMADR)

Bit	7	6	5	4	3	2	1	0
Field	TRMADR: Trim Bit Address (00H to 1FH)							
RESET	0	0	0	0	0	0	0	0
R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W
Address	FF6H							

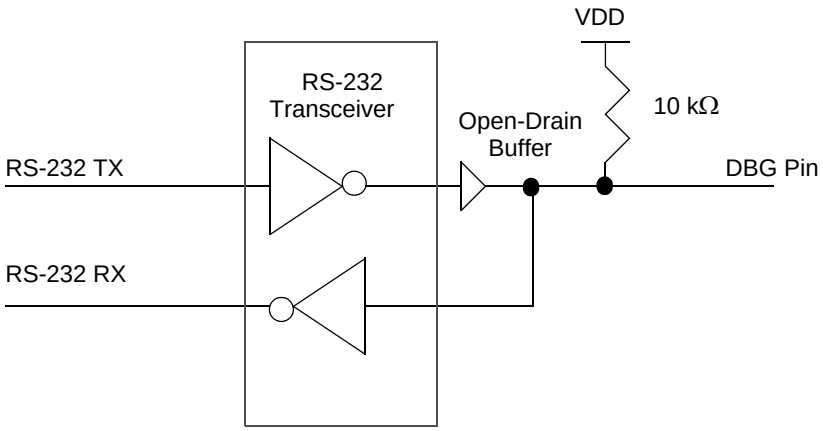

Figure 25. Interfacing the On-Chip Debugger's DBG Pin with an RS-232 Interface; #2 of 2

DEBUG Mode

The operating characteristics of the devices in DEBUG Mode are:

- The eZ8 CPU fetch unit stops, idling the eZ8 CPU, unless directed by the OCD to execute specific instructions
- The system clock operates unless in STOP Mode
- All enabled on-chip peripherals operate unless in STOP Mode
- Automatically exits HALT Mode
- Constantly refreshes the Watchdog Timer, if enabled

Entering DEBUG Mode

The operating characteristics of the devices entering DEBUG Mode are:

- The device enters DEBUG Mode after the eZ8 CPU executes a BRK (Breakpoint) instruction
- If the DBG pin is held Low during the final clock cycle of system reset, the part enters DEBUG Mode immediately (20-/28-pin products only)

Note: Holding the DBG pin Low for an additional 5000 (minimum) clock cycles after reset (making sure to account for any specified frequency error if using an internal oscillator) prevents a false interpretation of an Autobaud sequence (see the OCD Auto-Baud Detector/Generator section on page 183).

Oscillator Control

The Z8 Encore! XP F082A Series devices uses five possible clocking schemes, each user-selectable:

- Internal precision trimmed RC oscillator (IPO)
- On-chip oscillator using off-chip crystal or resonator
- On-chip oscillator using external RC network
- External clock drive
- On-chip low power Watchdog Timer oscillator
- Clock failure detection circuitry

In addition, Z8 Encore! XP F082A Series devices contain clock failure detection and recovery circuitry, allowing continued operation despite a failure of the system clock oscillator.

Operation

This chapter discusses the logic used to select the system clock and handle primary oscillator failures.

System Clock Selection

The oscillator control block selects from the available clocks. Table 112 details each clock source and its usage.

Table 114. Recommended Crystal Oscillator Specifications

Parameter	Value	Units	Comments
Frequency	20	MHz	
Resonance	Parallel		
Mode	Fundamental		
Series Resistance (R_S)	60	W	Maximum
Load Capacitance (C_L)	30	pF	Maximum
Shunt Capacitance (C_0)	7	pF	Maximum
Drive Level	1	mW	Maximum

Table 115. Transconductance Values for Low, Medium and High Gain Operating Modes

Mode	Crystal Frequency Range	Function	Transconductance (mA/V) (Use this range for calculations)		
Low Gain*	32kHz–1MHz	Low Power/Frequency Applications	0.02	0.04	0.09
Medium Gain*	0.5MHz–10MHz	Medium Power/Frequency Applications	0.84	1.7	3.1
High Gain*	8MHz–20MHz	High Power/Frequency Applications	1.1	2.3	4.2

Note: *Printed circuit board layouts must not add more than 4pF of stray capacitance to either the X_{IN} or X_{OUT} pins. if no oscillation occurs, reduce the values of the capacitors C1 and C2 to decrease the loading.

Assembly Language Source Program Example

```
JP START          ; Everything after the semicolon is a comment.
START:            ; A label called 'START'. The first instruction (JP START) in this
                  ; example causes program execution to jump to the point within the
                  ; program where the START label occurs.
LD R4, R7         ; A Load (LD) instruction with two operands. The first operand,
                  ; Working Register R4, is the destination. The second operand,
                  ; Working Register R7, is the source. The contents of R7 is
                  ; written into R4.
LD 234H, #%01     ; Another Load (LD) instruction with two operands.
                  ; The first operand, Extended Mode Register Address 234H,
                  ; identifies the destination. The second operand, Immediate Data
                  ; value 01H, is the source. The value 01H is written into the
                  ; Register at address 234H.
```

Assembly Language Syntax

For proper instruction execution, eZ8 CPU assembly language syntax requires that the operands be written as 'destination, source'. After assembly, the object code usually has the operands in the order 'source, destination', but ordering is opcode-dependent. The following instruction examples illustrate the format of some basic assembly instructions and the resulting object code produced by the assembler. This binary format must be followed if manual program coding is preferred or if you intend to implement your own assembler.

Example 1. If the contents of registers 43H and 08H are added and the result is stored in 43H, the assembly syntax and resulting object code is:

Table 116. Assembly Language Syntax Example 1

Assembly Language Code	ADD	43H,	08H	(ADD dst, src)
Object Code	04	08	43	(OPC src, dst)

Example 2. In general, when an instruction format requires an 8-bit register address, that address can specify any register location in the range 0–255 or, using Escaped Mode Addressing, a Working Register R0–R15. If the contents of Register 43H and Working Register R8 are added and the result is stored in 43H, the assembly syntax and resulting object code is:

Table 117. Assembly Language Syntax Example 2

Assembly Language Code	ADD	43H,	R8	(ADD dst, src)
Object Code	04	E8	43	(OPC src, dst)

Table 132. Power Consumption (Continued)

		V_{DD} = 2.7 V to 3.6 V				
Symbol	**Parameter**	**Typical[1]**	**Maximum Std Temp[2]**	**Maximum Ext Temp[3]**	**Units**	**Conditions**
I_{DD} ADCRef	ADC Internal Reference Supply Current	0			µA	See Note 4.
I_{DD} CMP	Comparator supply Current	150	180	190	µA	See Note 4.
I_{DD} LPO	Low-Power Operational Amplifier Supply Current	3	5	5	µA	Driving a high-impedance load.
I_{DD} TS	Temperature Sensor Supply Current	60			µA	See Note 4.
I_{DD} BG	Band Gap Supply Current	320	480	500	µA	For 20-/28-pin devices.
						For 8-pin devices.

Notes:
1. Typical conditions are defined as V_{DD} = 3.3V and +30°C.
2. Standard temperature is defined as T_A = 0°C to +70°C; these values not tested in production for worst case behavior, but are derived from product characterization and provided for design guidance only.
3. Extended temperature is defined as T_A = –40°C to +105°C; these values not tested in production for worst case behavior, but are derived from product characterization and provided for design guidance only.
4. For this block to operate, the bandgap circuit is automatically turned on and must be added to the total supply current. This bandgap current is only added once, regardless of how many peripherals are using it.

Figure 38 and Table 147 provide timing information for UART pins for the case where CTS is not used for flow control. DE asserts after the Transmit Data Register has been written. DE remains asserted for multiple characters as long as the Transmit Data Register is written with the next character before the current character has completed.

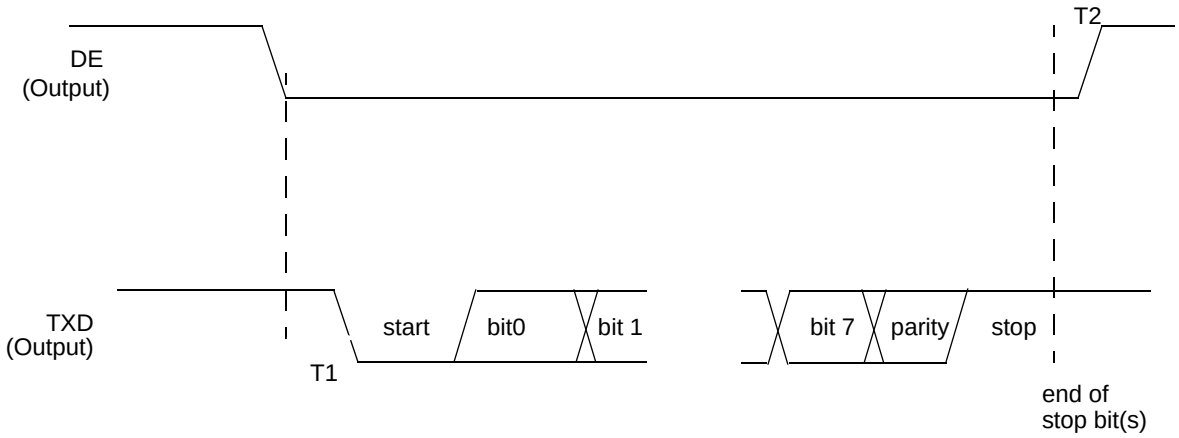

Figure 38. UART Timing Without CTS

Table 147. UART Timing Without CTS

		Delay (ns)	
Parameter	**Abbreviation**	**Minimum**	**Maximum**
UART			
T_1	DE assertion to TXD falling edge (start bit) delay	1 * X_{IN} period	1 bit time
T_2	End of Stop Bit(s) to DE deassertion delay (Tx Data Register is empty)	± 5	

Table 148. Z8 Encore! XP F082A Series Ordering Matrix

Part Number	Flash	RAM	NVDS	I/O Lines	Interrupts	16-Bit Timers w/PWM	10-Bit A/D Channels	UART with IrDA	Comparator	Temperature Sensor	Description
Z8 Encore! XP F082A Series Development Kit											
Z8F08A28100KITG	Z8 Encore! XP F082A Series 28-Pin Development Kit										
Z8F04A28100KITG	Z8 Encore! XP F042A Series 28-Pin Development Kit										
Z8F04A08100KITG	Z8 Encore! XP F042A Series 8-Pin Development Kit										
ZUSBSC00100ZACG	USB Smart Cable Accessory Kit										
ZUSBOPTSC01ZACG	USB Opto-Isolated Smart Cable Accessory Kit										
ZENETSC0100ZACG	Ethernet Smart Cable Accessory Kit										